

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT PTO FORM 1449</b>	<b>ATTY. DOCKET NO.</b> 2345/163	<b>SERIAL NO.</b> Not yet assigned
	<b>APPLICANT(s)</b>  Norbert HANIK et al.	
	<b>FILING DATE</b> Herewith	<b>GROUP</b> Not yet assigned

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	PATENT DATE	NAME

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
				YES	NO

OTHER DOCUMENTS

EXAMINER INITIAL		AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
LP		*Mueller, et al., "Application of Amplitude Histograms For Quality of Service Measurements of Optical Channels and Fault Identification," ECOC98, September 20-24, 1998, Madrid, Spain, pages 707-708.
LP		*Patent Abstracts of Japan, & JP 10 239214 A, vol. 1998, no. 14, September 11, 1998.
LP		*Shake, et al., "Optical Signal Quality Monitoring Method Based on Optical Sampling," Electronics Letters, vol. 34, no. 22, October 23, 1998, pages 2152-2154.
LP		*Atsushi Hiramatsu, "Training Techniques for Neural Network Applications in ATM," IEEE Service Center, New Jersey, U.S.A., vol. 33, no. 10, October 1, 1995, pages 58, 63-67.

\*Copy of reference is not enclosed because reference is cited and described in International Search Report (copy of reference provided by International Searching Authority).

<b>EXAMINER</b> <i>Heslie Parcel</i>	<b>DATE CONSIDERED</b> <i>10-1-04</i>
<b>EXAMINER:</b> Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	